## Notice of References Cited

Application/Control No. 10/017,416

Applicant(s)/Patent Under Reexamination CHOI ET AL.

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HOAN C. NGUYEN

Art Unit 2871

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## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5479284	12-1995	Watanabe et al.	349/189
	В	US-5355236	10-1994	Mitsui	349/189
	С	US-6271907	08-2001	Masaki et al.	349/189
	D	US-6104467	08-2000	Nakahara et al.	349/189
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
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	R					
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## **NON-PATENT DOCUMENTS**

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